

P-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}\left(\Omega\right)$	I _D (A) ^d	Q _g (Typ.)			
- 30	0.005 at V _{GS} = - 10 V	- 29	61 nC			
- 30	0.00775 at $V_{GS} = -4.5 \text{ V}$	- 23				

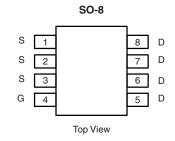
FEATURES

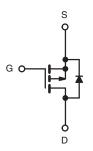
- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET® Power MOSFET
- 100 % R_g and UIS Tested
- Compliant to RoHS Directive 2002/95/EC



APPLICATIONS

- Adaptor Switch
- Notebook





Ordering Information: Si4459ADY-T1-GE3 (Lead (Pb)-free and Halogen-free)

P-Channel MOSFET

Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	V _{DS}	- 30	V		
Gate-Source Voltage	V _{GS}	± 20	V		
	T _C = 25 °C		- 29		
Continuous Drain Current /T 150 °C)	T _C = 70 °C		- 23.5		
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	I _D	- 19.7 ^{a, b}		
	T _A = 70 °C		- 15.6 ^{a, b}		
Pulsed Drain Current	I _{DM}	- 70	Α		
Continuous Course Dunin Diada Current	T _C = 25 °C		- 6.5		
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	- 2.9 ^{a, b}		
Avalanche Current	1 04 mill	I _{AS}	- 30		
Single-Pulse Avalanche Energy	L = 0.1 mH	E _{AS}	45	mJ	
	T _C = 25 °C		7.8		
Manianum Davina Disabatian	T _C = 70 °C	ь —	5	w	
Maximum Power Dissipation	T _A = 25 °C	P _D	3.5 ^{a, b}	VV	
	T _A = 70 °C		2.2 ^{a, b}		
Operating Junction and Storage Temperature Rang	T _J , T _{stg}	- 55 to 150	°C		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{a, c}	t ≤ 10 s	R _{thJA}	29	35	°C/W	
Maximum Junction-to-Foot	Steady State	R _{thJF}	13	16	C/VV	

Notes:

- a. Surface mounted on 1" x 1" FR4 board.
- b. t = 10 s.
- c. Maximum under steady state conditions is 80 °C/W.
- d. Based on $T_C = 25$ °C.



SPECIFICATIONS ($T_J = 25$ °	C, unless oth	nerwise noted)					
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	- 30			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = - 250 μA		- 31		m\//°C	
V _{GS(th)} Temperature Coefficient				5.3		mV/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = - 250 μA			- 2.5	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
		$V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}$			- 100		
Zara Cata Valtaga Drain Current	I	V _{DS} = - 20 V, V _{GS} = 0 V			- 75	μΑ	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = - 30 V, V _{GS} = 0 V, T _J = 75 °C			- 10		
		V _{DS} = - 20 V, V _{GS} = 0 V, T _J = 75 °C			- 3		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge -10 \text{ V}, V_{GS} = -10 \text{ V}$	- 30			Α	
	D	V _{GS} = - 10 V, I _D = - 15 A		0.0039	0.005	Ω	
Drain-Source On-State Resistance ^a	$R_{DS(on)}$	V _{GS} = - 4.5 V, I _D = - 10 A		0.0062	0.00775		
Forward Transconductancea	9 _{fs}	V _{DS} = - 10 V, I _D = - 15 A		24		S	
Dynamic ^b					L	L	
Input Capacitance	C _{iss}			6000			
Output Capacitance	C _{oss}	$V_{DS} = -15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		860		pF	
Reverse Transfer Capacitance	C _{rss}			790			
Tatal Oats Observe		$V_{DS} = -15 \text{ V}, V_{GS} = -10 \text{ V}, I_{D} = -20 \text{ A}$		129	195		
Total Gate Charge	Q_g			61	95		
Gate-Source Charge	Q_{gs}	$V_{DS} = -15 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -20 \text{ A}$		16.5		nC	
Gate-Drain Charge	Q _{qd}			23.5			
Gate Resistance	R _q	f = 1 MHz	0.6	3	6	Ω	
Turn-On Delay Time	t _{d(on)}			16	30		
Rise Time	t _r	$V_{DD} = -15 \text{ V}, R_{L} = 1.5 \Omega$		16	30	1	
Turn-Off DelayTime	t _{d(off)}	$I_D \cong$ - 10 A, V_{GEN} = - 10 V, R_g = 1 Ω		80	150		
Fall Time	t _f	, and the second		20	40		
Turn-On Delay Time	t _{d(on)}			75	150	ns	
Rise Time	t _r	$V_{DD} = -15 \text{ V}, R_{L} = 1.5 \Omega$		130	260	1 - -	
Turn-Off DelayTime	t _{d(off)}	$I_D \cong -10 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_g = 1 \Omega$		60	120		
Fall Time	t _f	Ţ		40	80		
Drain-Source Body Diode Characteris	stics			•	l .	I.	
Continous Source-Drain Diode Current	I _S	T _C = 25 °C			- 29	_	
Pulse Diode Forward Current	I _{SM}	-			- 70	Α	
Body Diode Voltage	V _{SD}	I _S = - 3 A, V _{GS} = 0 V		- 0.71	- 1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			67	130	ns	
Body Diode Reverse Recovery Charge	/ Diode Reverse Recovery Charge			74	150	nC	
Reverse Recovery Fall Time	t _a	$I_F = -5 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		22			
Reverse Recovery Rise Time	t _b	_		45		ns	

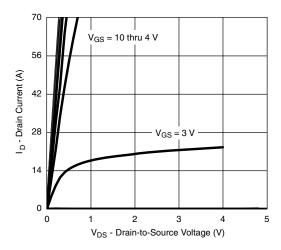
Notes:

- a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.
- b. Guaranteed by design, not subject to production testing.

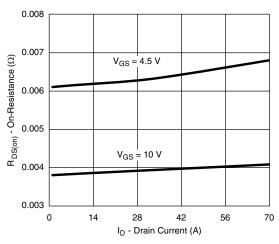
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



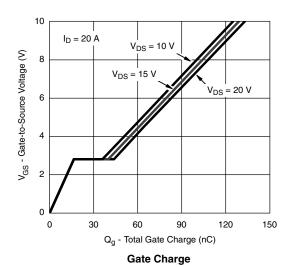
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

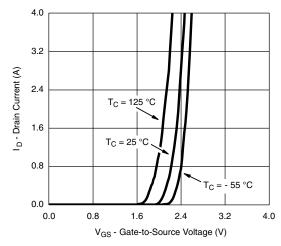


Output Characteristics

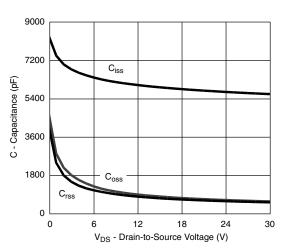


On-Resistance vs. Drain Current

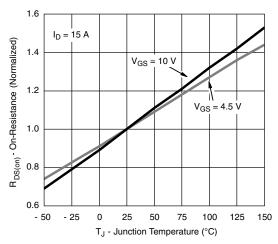




Transfer Characteristics

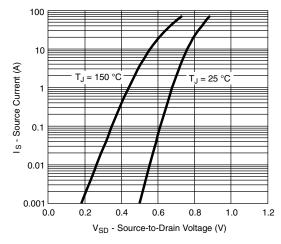


Capacitance

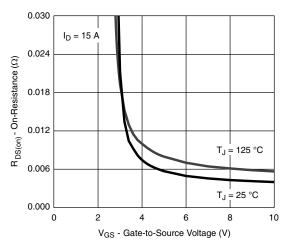


On-Resistance vs. Junction Temperature

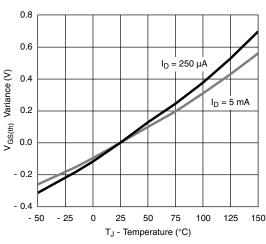
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



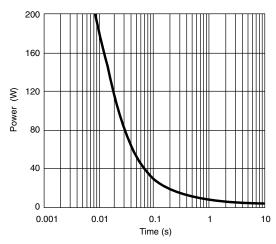
Source-Drain Diode Forward Voltage



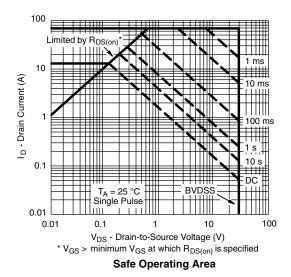
On-Resistance vs. Gate-to-Source Voltage



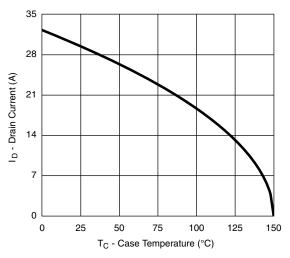
Threshold Voltage



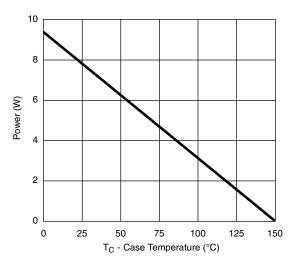
Single Pulse Power, Junction-to-Ambient



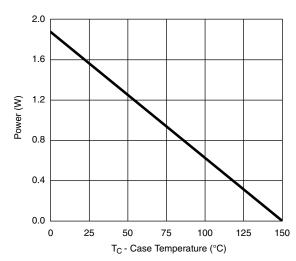
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Current Derating*



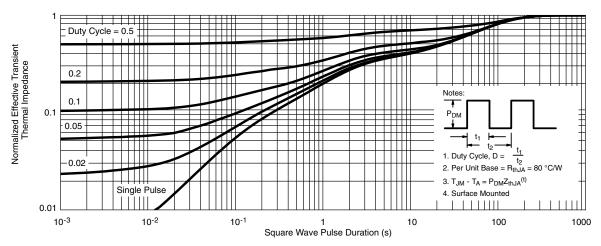




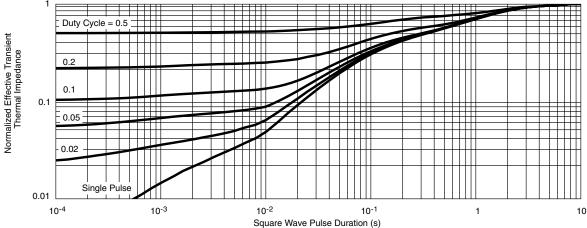
Power Derating, Junction-to-Ambient

 $^{^{\}star}$ The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

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SOIC (NARROW): 8-LEAD JEDEC Part Number: MS-012







	MILLIM	IETERS	INCHES			
DIM	Min	Max	Min	Max		
Α	1.35	1.75	0.053	0.069		
A ₁	0.10	0.20	0.004	0.008		
В	0.35	0.51	0.014	0.020		
С	0.19	0.25	0.0075	0.010		
D	4.80	5.00	0.189	0.196		
Е	3.80	4.00	0.150	0.157		
е	1.27	BSC	0.050 BSC			
Н	5.80	6.20	0.228	0.244		
h	0.25	0.50	0.010	0.020		
L	0.50	0.93	0.020	0.037		
q	0°	8°	0°	8°		
S	0.44	0.64	0.018	0.026		
FCN: C-06527-Bev						

ECN: C-06527-Rev. I, 11-Sep-06

DWG: 5498

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RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)

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